

1.8-V PHASE LOCK LOOP CLOCK DRIVER

SCAS688D–JUNE 2005–REVISED JULY 2007

FEATURES

- 1.8-V Phase Lock Loop Clock Driver for Double Data Rate (DDR II) Applications
- Spread Spectrum Clock Compatible
- Operating Frequency: 10 MHz to 400 MHz
- Low Current Consumption: <135 mA
- Low Jitter (Cycle-Cycle): ± 30 ps
- Low Output Skew: 35 ps
- Low Period Jitter: ± 20 ps
- Low Dynamic Phase Offset: ± 15 ps
- Low Static Phase Offset: ± 50 ps
- Distributes One Differential Clock Input to Ten Differential Outputs
- 52-Ball μ BGA (MicroStar™ Junior BGA, 0,65-mm pitch) and 40-Pin MLF
- External Feedback Pins (FBIN, $\overline{\text{FBIN}}$) are Used to Synchronize the Outputs to the Input Clocks
- Meets or Exceeds JESD82-8 PLL Standard for PC2-3200/4300
- Fail-Safe Inputs

DESCRIPTION

The CDCU877 is a high-performance, low-jitter, low-skew, zero-delay buffer that distributes a differential clock input pair (CK, $\overline{\text{CK}}$) to ten differential pairs of clock outputs (Yn, $\overline{\text{Yn}}$) and to one differential pair of feedback clock outputs (FBOU, $\overline{\text{FBOU}}$). The clock outputs are controlled by the input clocks (CK, $\overline{\text{CK}}$), the feedback clocks (FBIN, $\overline{\text{FBIN}}$), the LVCMOS control pins (OE, OS), and the analog power input (AV_{DD}). When OE is low, the clock outputs, except FBOU/ $\overline{\text{FBOU}}$, are disabled while the internal PLL continues to maintain its locked-in frequency. OS (output select) is a program pin that must be tied to GND or V_{DD}. When OS is high, OE functions as previously described. When OS and OE are both low, OE has no effect on Y7/ $\overline{\text{Y7}}$, they are free running. When AV_{DD} is grounded, the PLL is turned off and bypassed for test purposes.

When both clock inputs (CK, $\overline{\text{CK}}$) are logic low, the device enters in a low power mode. An input logic detection circuit on the differential inputs, independent from input buffers, detects the logic low level and performs in a low power state where all outputs, the feedback, and the PLL are off. When the clock inputs transition from being logic low to being differential signals, the PLL turns back on, the inputs and the outputs are enabled, and the PLL obtains phase lock between the feedback clock pair (FBIN, $\overline{\text{FBIN}}$) and the clock input pair (CK, $\overline{\text{CK}}$) within the specified stabilization time.

The CDCU877 is able to track spread spectrum clocking (SSC) for reduced EMI. This device operates from -40°C to 85°C .

ORDERING INFORMATION

T _A	52-BALL BGA ⁽¹⁾	40-Pin MLF
-40°C to 85°C	CDCU877ZQL	CDCU877RHA
	CDCU877AZQL	CDCU877ARHA
	CDCU877GQL	CDCU877RTB
	CDCU877AGQL	CDCU877ARTB

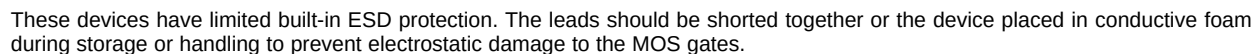
- (1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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[illegible]

- A. NC = No Connection
B. NB = No Ball

40-pin HP-VFQFP-N (6,0 x 6,0 mm Body Size,
0,5 mm Pitch, M0#220, Variation VJJD-2,
E2 = D2 = 2,9 mm $\pm$ 0,15 mm) Package Pinouts

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TERMINAL FUNCTIONS

TERMINAL		I/O	DESCRIPTION
NAME	GQL/ZQL		
AGND	G1	7	Analog ground
AV _{DD}	H1	8	Analog power
CK	E1	4	Clock input with a (10 k Ω to 100 k Ω) pulldown resistor
$\overline{\text{CK}}$	F1	5	Complementary clock input with a (10 k Ω to 100 k Ω) pulldown resistor
FBIN	E6	27	Feedback clock input
$\overline{\text{FBIN}}$	F6	26	Complementary feedback clock input
FBOU _T	H6	24	Feedback clock output
$\overline{\text{FBOU}}\overline{\text{T}}$	G6	25	Complementary feedback clock output
OE	F5	22	Output enable (asynchronous)
OS	D5	21	Output select (tied to GND or V _{DD})
GND	B2, B3, B4, B5, C2, C5, H2, H5, J2, J3, J4, J5	10	Ground
V _{DDQ}	D2, D3, D4, E2, E5, F2, G2, G3, G4, G5	1, 6, 9, 15, 20, 23, 28, 31, 36	Logic and output power
Y[0:9]	A2, A1, D1, J1, K3, A5, A6, D6, J6, K4	3, 11, 14, 16, 19, 29, 33, 34, 38, 39	Clock outputs
$\overline{\text{Y}}[0:9]$	A3, B1, C1, K1, K2, A4, B6, C6, K6, K5	2, 12, 13, 18, 17, 30, 32, 35, 37, 40	Complementary clock outputs

FUNCTION TABLE

INPUTS					OUTPUTS				
AVDD	OE	OS	CK	$\overline{\text{CK}}$	Y	$\overline{\text{Y}}$	FBOU _T	$\overline{\text{FBOU}}\overline{\text{T}}$	PLL
GND	H	X	L	H	L	H	L	H	Bypassed/Off
GND	H	X	H	L	H	L	H	L	Bypassed/Off
GND	L	H	L	H	L _Z	L _Z	L	H	Bypassed/Off
GND	L	L	H	L	L _Z Y7 Active	L _Z $\overline{\text{Y}}\overline{7}$ Active	H	L	Bypassed/Off
1.8 V Nominal	L	H	L	H	L _Z	L _Z	L	H	On
1.8 V Nominal	L	L	H	L	L _Z Y7 Active	L _Z $\overline{\text{Y}}\overline{7}$ Active	H	L	On
1.8 V Nominal	H	X	L	H	L	H	L	H	On
1.8 V Nominal	H	X	H	L	H	L	H	L	On
1.8 V Nominal	X	X	L	L	L _Z	L _Z	L _Z	L _Z	Off
X	X	X	H	H	Reserved				

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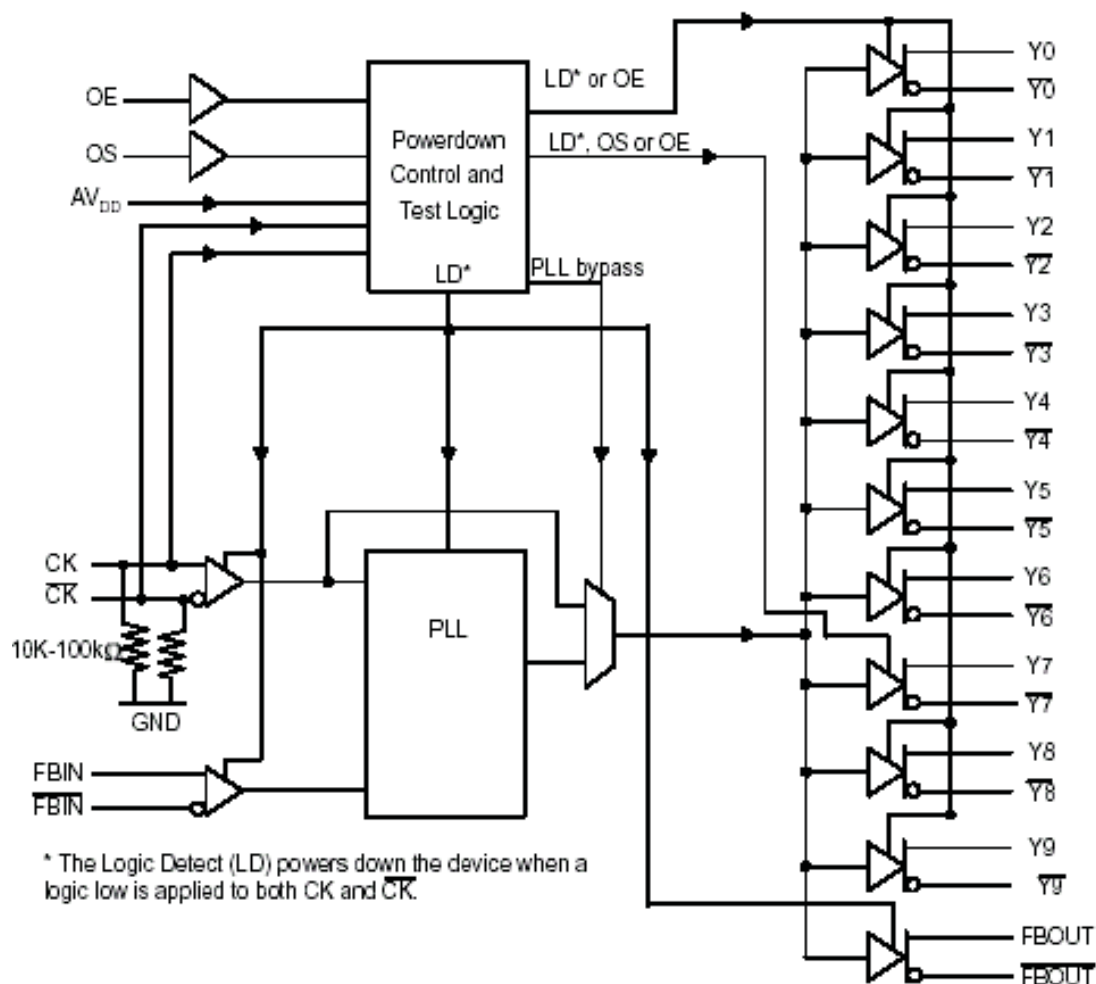


Figure 1. LOGIC DIAGRAM (POSITIVE LOGIC)

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Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range	V _{DDQ} or AV _{DD}	–0.5	2.5	V
V _I	Input voltage range ⁽²⁾⁽³⁾		–0.5	V _{DDQ} + 0.5	V
V _O	Output voltage range ⁽²⁾⁽³⁾		–0.5	V _{DDQ} + 0.5	V
I _{IK}	Input clamp current	V _I < 0 or V _I > V _{DDQ}		±50	mA
I _{OK}	Output clamp current	V _O < 0 or V _O > V _{DDQ}		±50	mA
I _O	Continuous output current	V _O = 0 to V _{DDQ}		±50	mA
	Continuous current through each V _{DDQ} or GND			±100	mA
T _{stg}	Storage temperature range		–65	150	°C

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (3) This value is limited to 2.5 V maximum.

Recommended Operating Conditions

			MIN	NOM	MAX	UNIT
V _{CC}	Output supply voltage, V _{DDQ}		1.7	1.8	1.9	V
	Supply Voltage, AV _{DD} ⁽¹⁾			V _{DDQ}		V
V _{IL}	Low-level input voltage ⁽²⁾	OE, OS			0.35 × V _{DDQ}	V
V _{IH}	High-level input voltage ⁽²⁾	CK, $\overline{\text{CK}}$	0.65 × V _{DDQ}			V
I _{OH}	High-level output current (see Figure 2)				–9	mA
I _{OL}	Low-level output current (see Figure 2)				9	mA
V _{IX}	Input differential-pair cross voltage		(V _{DDQ} /2) – 0.15		(V _{DDQ} /2) + 0.15	V
V _I	Input voltage level		–0.3		V _{DDQ} + 0.3	V
V _{ID}	Input differential voltage ⁽²⁾ (see Figure 9)	DC	0.3		V _{DDQ} + 0.4	V
		AC	0.6		V _{DDQ} + 0.4	V
T _A	Operating free-air temperature		–40		85	°C

- (1) The PLL is turned off and bypassed for test purposes when AV_{DD} is grounded. During this test mode, V_{DDQ} remains within the recommended operating conditions and no timing parameters are specified.
- (2) V_{ID} is the magnitude of the difference between the input level on CK and the input level on $\overline{\text{CK}}$, see Figure 9 for definition. The CK and $\overline{\text{CK}}$, V_{IH} and V_{IL} limits define the dc low and high levels for the logic detect state.

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Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	AV _{DD} , V _{DDQ}	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{IK}	Input	I _I = 18 mA	1.7			-1.2	V
V _{OH}	High-level output voltage	I _{OH} = -100 µA	1.7 to 1.9	V _{DDQ} - 0.2			V
		I _{OH} = -9 mA	1.7	1.1			
V _{OL}	Low-level output voltage	I _{OL} = 100 µA				0.1	V
		I _{OL} = 9 mA	1.7			0.6	
I _{O(DL)}	Low-level output current, dissabled	V _{O(DL)} = 100 mV, OE = L	1.7	100			µA
V _{OD}	Differential output voltage ⁽¹⁾		1.7	0.5			V
I _I	Input current	CK, $\overline{\text{CK}}$	1.9			±250	µA
		OE, OS, FBIN, $\overline{\text{FBIN}}$	1.9			±10	
I _{DD(LD)}	Supply current, static (I _{DDQ} + I _{ADD})	CK and $\overline{\text{CK}}$ = L	1.9			500	µA
I _{DD}	Supply current, dynamic (I _{DDQ} + I _{ADD}) (see Note ⁽²⁾ for CPD calculation)	CK and $\overline{\text{CK}}$ = 270 MHz. All outputs are open (not connected to a PCB)	1.9			135	mA
		All outputs are loaded with 2 pF and 120-Ω termination resistor	1.9			235	
C _I	Input capacitance	CK, $\overline{\text{CK}}$	V _I = V _{DD} or GND	1.8	2	3	pF
		FBIN, $\overline{\text{FBIN}}$		1.8	2	3	
C _{I(Δ)}	Change in input current	CK, $\overline{\text{CK}}$	V _I = V _{DD} or GND	1.8		0.25	
		FBIN, $\overline{\text{FBIN}}$		1.8		0.25	

(1) V_{OD} is the magnitude of the difference between the true and complimentary outputs. See Figure 9 for a definition.(2) Total I_{DD} = I_{DDQ} + I_{ADD} = f_{CK} × C_{PD} × V_{DDQ}, solving for C_{PD} = (I_{DDQ} + I_{ADD})/(f_{CK} × V_{DDQ}) where f_{CK} is the input frequency, V_{DDQ} is the power supply, and C_{PD} is the power dissipation capacitance.

Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted)⁽¹⁾

PARAMETER		TEST CONDITIONS	MIN	MAX	UNIT
f _{CK}	Clock frequency (operating) ⁽¹⁾⁽²⁾	AV _{DD} , V _{DD} = 1.8 V ±0.1 V	10	400	MHz
	Clock frequency (application) ⁽¹⁾⁽³⁾		160	340	MHz
t _{DC}	Duty cycle, input clock		40%	60%	
t _L	Stabilization time ⁽⁴⁾			12	µs

(1) The PLL must be able to handle spread spectrum induced skew.

(2) Operating clock frequency indicates a range over which the PLL must be able to lock, but in which it is not required to meet the other timing parameters (used for low speed system debug).

(3) Application clock frequency indicates a range over which the PLL must meet all timing parameters.

(4) Stabilization time is the time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal after power up. During normal operation, the stabilization time is also the time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal when CK and $\overline{\text{CK}}$ go to a logic low state, enter the power-down mode and later return to active operation. CK and $\overline{\text{CK}}$ may be left floating after they have been driven low for one complete clock cycle.

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Switching Characteristics

over recommended operating free-air temperature range (unless otherwise noted) (see ⁽¹⁾) AV_{DD} , $V_{DD} = 1.8\text{ V} \pm 0.1\text{ V}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{en}	Enable time, OE to any $\overline{Y}/\overline{Y}$	See Figure 11			8	ns
t_{dis}	Disable time, OE to any $\overline{Y}/\overline{Y}$	See Figure 11			8	ns
$t_{jit(cc+)}$	Cycle-to-cycle period jitter ⁽²⁾	160 MHz to 190 MHz, see Figure 4	0		40	ps
$t_{jit(cc-)}$			0		-40	
$t_{jit(cc+)}$	Cycle-to-cycle period jitter ⁽²⁾	160 MHz to 340 MHz, see Figure 4	0		30	ps
$t_{jit(cc-)}$			0		-30	
$t_{(w)}$	Static phase offset time ⁽³⁾	See Figure 5	-50		50	ps
$t_{(w)dyn}$	Dynamic phase offset time	See Figure 10	-15		15	ps
$t_{sk(o)}$	Output clock skew	See Figure 6			35	ps
$t_{jit(per)}$	Period jitter ⁽⁴⁾⁽²⁾	160 MHz to 190 MHz, see Figure 7	-30		30	ps
		190 MHz to 340 MHz, see Figure 7	-20		20	
$t_{jit(hper)}$	Half-period jitter ⁽⁴⁾⁽²⁾	160 MHz to 190 MHz, see Figure 8	-115		115	ps
		190 MHz to 250 MHz, see Figure 8	-70		70	
		250 MHz to 300 MHz, see Figure 8	-40		40	
		300 MHz to 340 MHz, see Figure 8	-60		60	
SR	Slew rate, OE	See Figure 3 and Figure 9	0.5			V/ns
	Input clock slew rate	See Figure 3 and Figure 9	1	2.5	4	
	Output clock slew rate ⁽⁵⁾⁽⁶⁾ (no load)	See Figure 3 and Figure 9	1.5	2.5	3	
V_{OX}	Output differential-pair cross voltage ⁽⁷⁾	CDCU877, See Figure 2	$(V_{DDQ}/2) - 0.1$		$(V_{DDQ}/2) + 0.1$	V
		CDCU877A ⁽⁸⁾ , See Figure 2 (0 - 85°C)	$(V_{DDQ}/2) - 0.1$		$(V_{DDQ}/2) + 0.1$	
	SSC modulation frequency		30		33	kHz
	SSC clock input frequency deviation		0%		-0.5%	
	PLL loop bandwidth		2			MHz

- (1) There are two different terminations that are used with the following tests. The load/board in Figure 2 is used to measure the input and output differential-pair cross voltage only. The load/board in Figure 3 is used to measure all other tests. For consistency, equal length cables must be used.
- (2) This parameter is specified by design and characterization.
- (3) Phase static offset time does not include jitter.
- (4) Period jitter, half-period jitter specifications are separate specifications that must be met independently of each other.
- (5) The output slew rate is determined from the IBIS model with a 120-Ω load only.
- (6) To eliminate the impact of input slew rates on static phase offset, the input skew rates of reference clock input CK and $\overline{CK}$ and feedback clock inputs FBIN and $\overline{FBIN}$ are recommended to be nearly equal. The 2.5-V/ns skew rates are shown as a recommended target. Compliance with these typical values is not mandatory if it can adequately shown that alternative characteristics meet the requirements of the registered DDR2 DIMM application.
- (7) Output differential-pair cross voltage specified at the DRAM clock input or the test load.
- (8) V_{OX} of CDCU877A is on average 30 mV lower than that of CDCU877 for the same application.

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PARAMETER MEASUREMENT INFORMATION

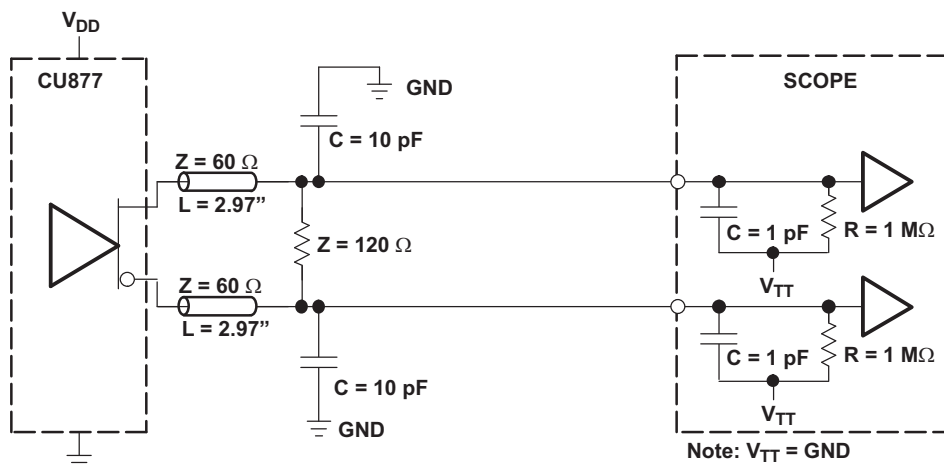


Figure 2. Output Load Test Circuit 1

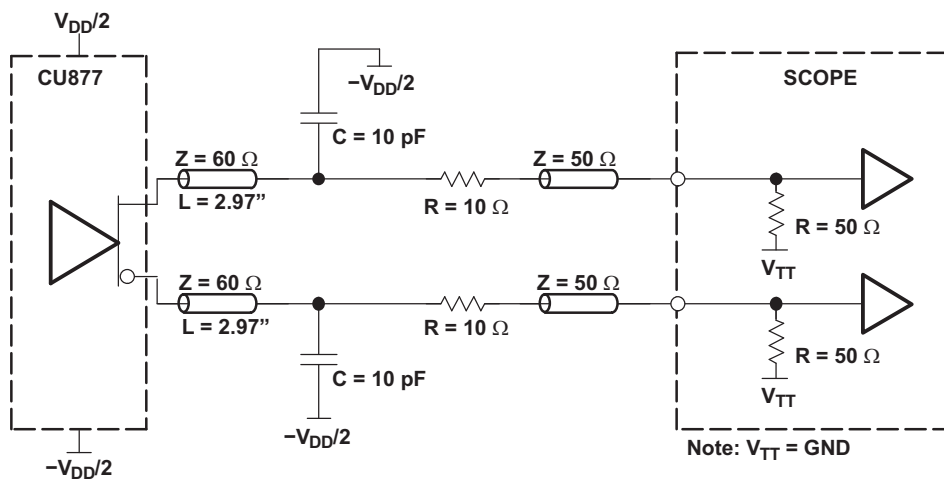


Figure 3. Output Load Test Circuit 2

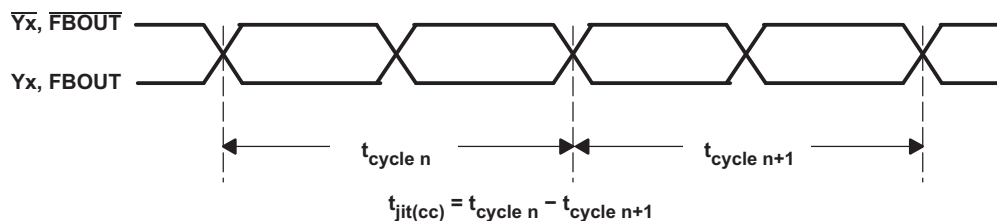


Figure 4. Cycle-To-Cycle Period Jitter

PARAMETER MEASUREMENT INFORMATION (continued)

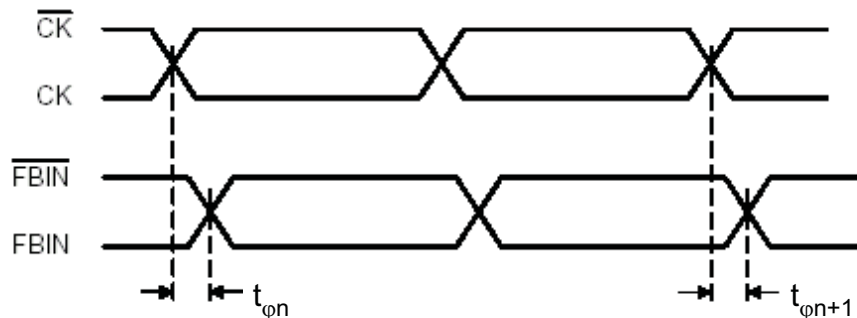


Figure 5. Static Phase Offset

$$t_{\phi} = \frac{\sum_{n=1}^N t_{\phi n}}{N}$$

(N is the large number of samples)

(N > 1000 samples)

(1)

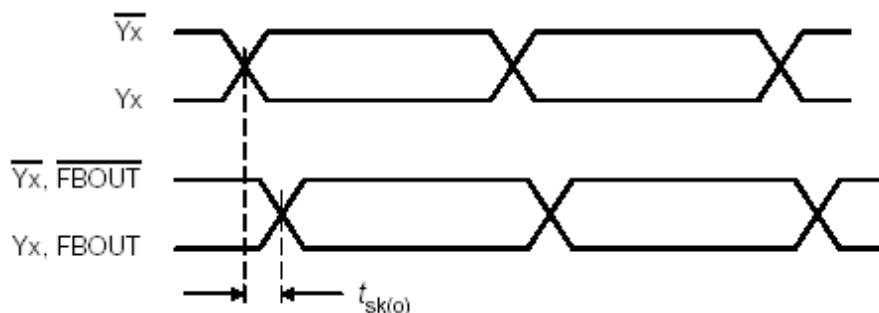


Figure 6. Output Skew

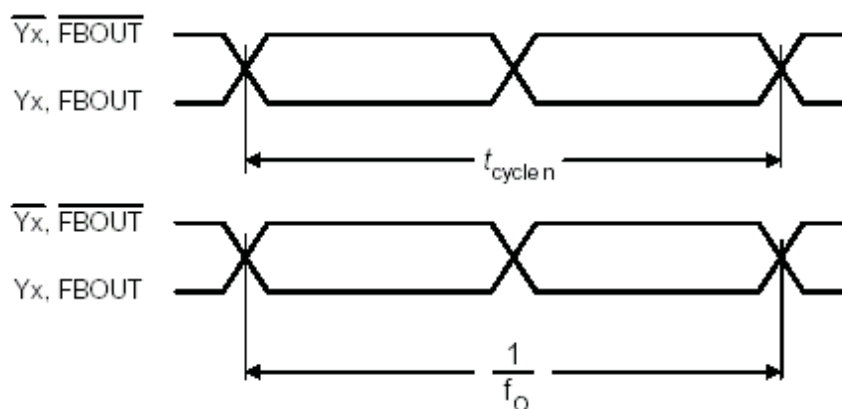


Figure 7. Period Jitter

$$t_{jit(per)} = t_{cycle n} - \frac{1}{f_o}$$

(f_o average input frequency measured at CK/CK-bar)

(2)

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PARAMETER MEASUREMENT INFORMATION (continued)

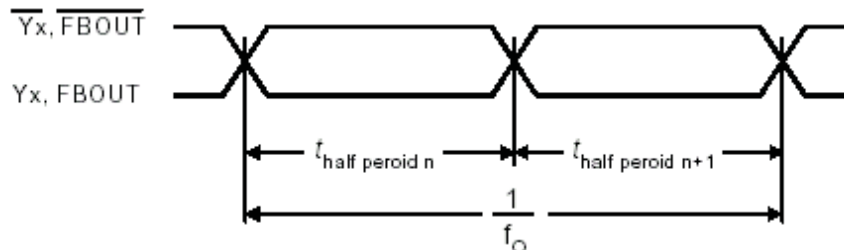


Figure 8. Half-Period Jitter

$$t_{jit(hper)} = t_{half\ period\ n} - \frac{1}{2 \times f_O}$$

n = any half cycle

(f_O average input frequency measured at CK/ $\overline{CK}$)

(3)

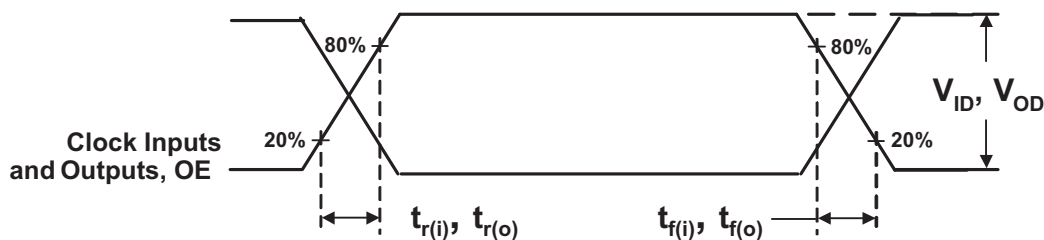


Figure 9. Input and Output Slew Rates

$$slrr_{(i/o)} = \frac{V_{80\%} - V_{20\%}}{t_{r(i/o)}}$$

$$slrf_{(i/o)} = \frac{V_{80\%} - V_{20\%}}{t_{f(i/o)}}$$

(4)

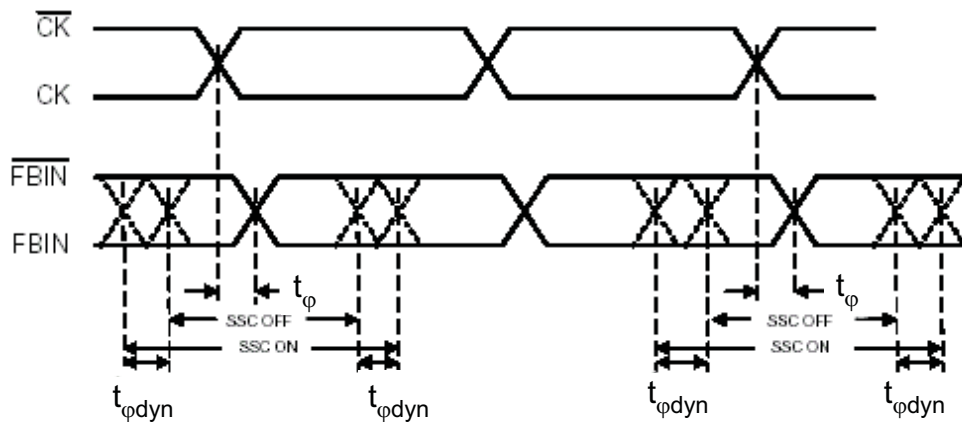


Figure 10. Dynamic Phase Offset

PARAMETER MEASUREMENT INFORMATION (continued)

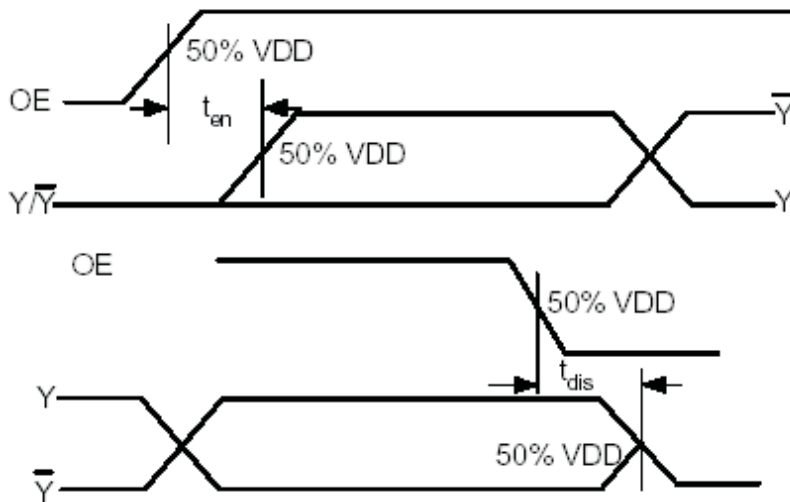
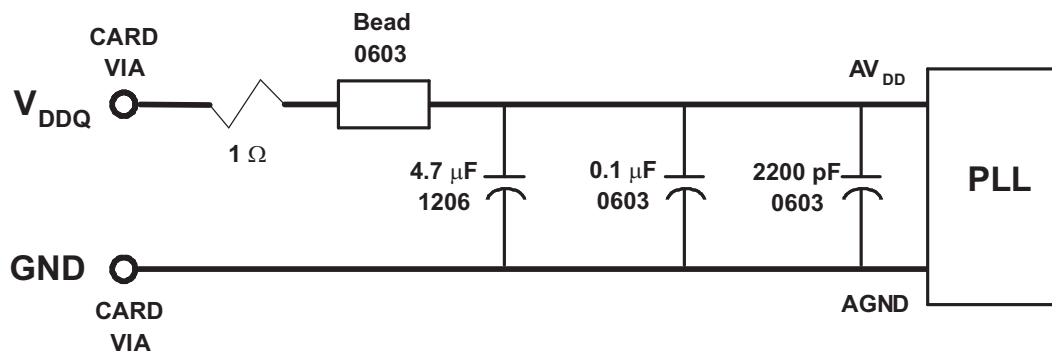


Figure 11. Time Delay Between OE and Clock Output (Y, $\bar{Y}$)

RECOMMENDED AV_{DD} FILTERING



- Place the 2200-pF capacitor close to the PLL.
- Use a wide trace for the PLL analog power and ground. Connect PLL and capacitors to AGND trace and connect trace to one GND via (farthest from the PLL).
- Recommended bead: Fair-Rite PN 2506036017Y0 or equivalent (0.8 Ω dc maximum, 600 Ω at 100 MHz).

Figure 12. Recommended AV_{DD} Filtering

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CDCU877ANMKR	Active	Production	NFBGA (NMK) 52	1000 LARGE T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	CDCU877A
CDCU877ANMKR.A	Active	Production	NFBGA (NMK) 52	1000 LARGE T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	CDCU877A
CDCU877ANMKT	Active	Production	NFBGA (NMK) 52	250 SMALL T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	CDCU877A
CDCU877ANMKT.A	Active	Production	NFBGA (NMK) 52	250 SMALL T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	CDCU877A
CDCU877ARHAR	Active	Production	VQFN (RHA) 40	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877A
CDCU877ARHAR.A	Active	Production	VQFN (RHA) 40	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877A
CDCU877ARHARG4	Active	Production	VQFN (RHA) 40	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877A
CDCU877ARHAT	Active	Production	VQFN (RHA) 40	250 SMALL T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877A
CDCU877ARHAT.A	Active	Production	VQFN (RHA) 40	250 SMALL T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877A
CDCU877ARHATG4	Active	Production	VQFN (RHA) 40	250 SMALL T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877A
CDCU877ARHATG4.A	Active	Production	VQFN (RHA) 40	250 SMALL T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877A
CDCU877RHAR	Active	Production	VQFN (RHA) 40	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877
CDCU877RHAR.A	Active	Production	VQFN (RHA) 40	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877
CDCU877RHARG4	Active	Production	VQFN (RHA) 40	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877
CDCU877RHARG4.A	Active	Production	VQFN (RHA) 40	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877
CDCU877RHAT	Active	Production	VQFN (RHA) 40	250 SMALL T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877
CDCU877RHAT.A	Active	Production	VQFN (RHA) 40	250 SMALL T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877
CDCU877RHATG4	Active	Production	VQFN (RHA) 40	250 SMALL T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877
CDCU877RTBR	Active	Production	VQFN (RHA) 40	2500 LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 85	CDCU877

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

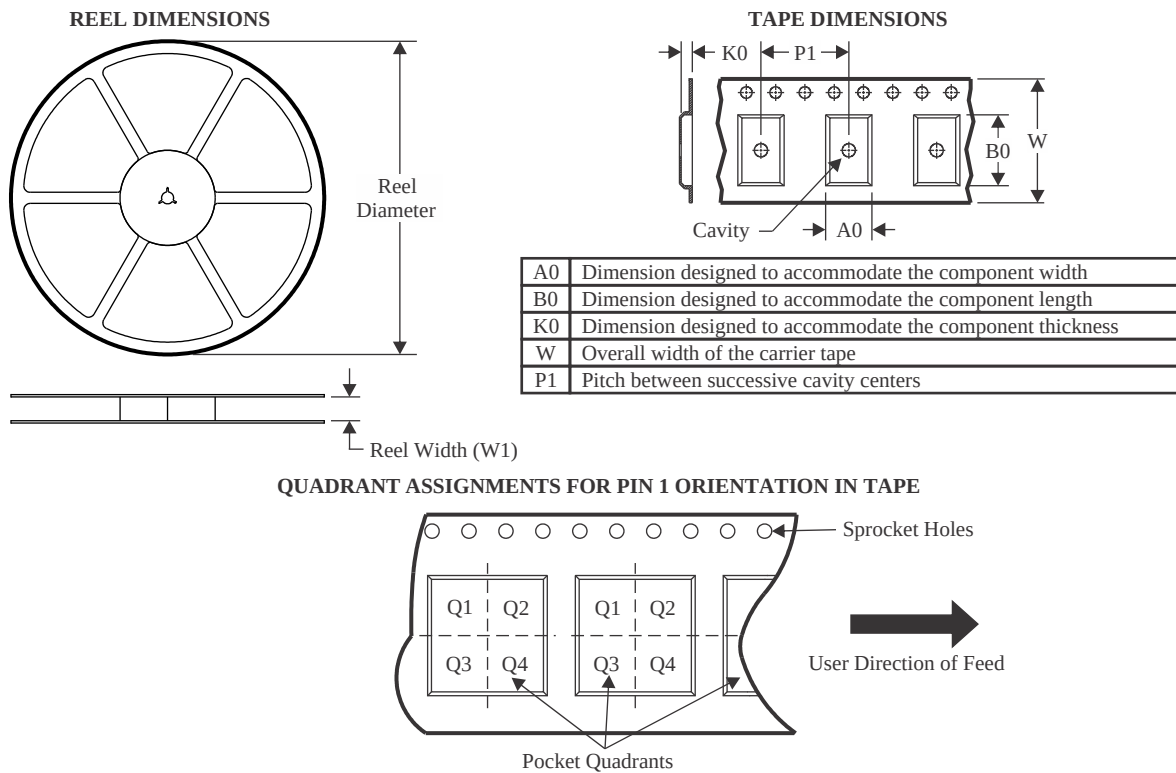
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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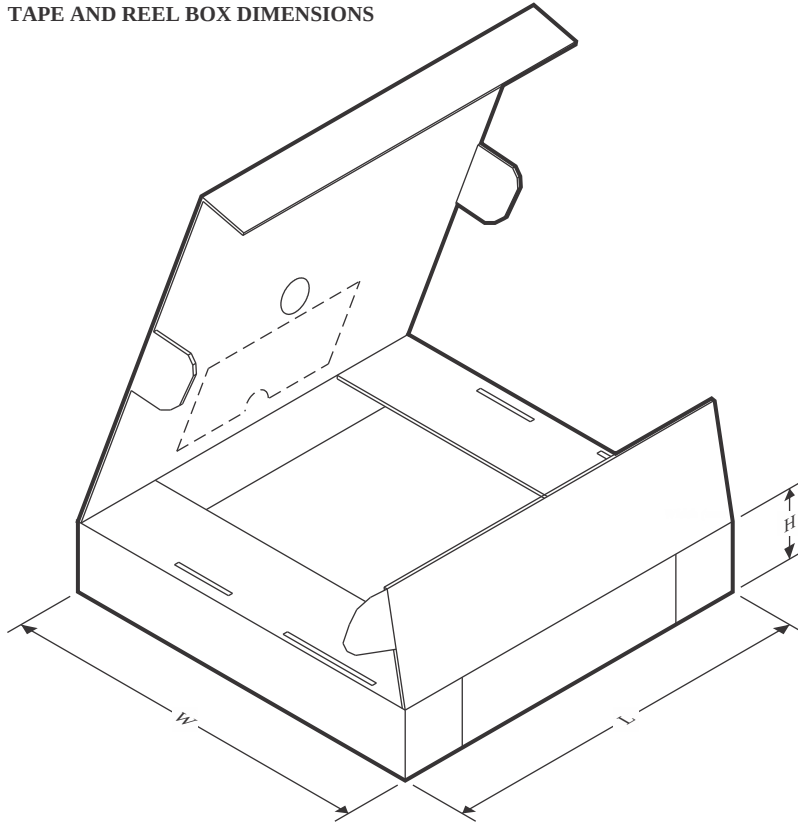
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCU877ANMKR	NFBGA	NMK	52	1000	330.0	16.4	4.8	7.3	1.5	8.0	16.0	Q1
CDCU877ARHAR	VQFN	RHA	40	2500	330.0	16.4	6.3	6.3	1.1	12.0	16.0	Q2
CDCU877ARHATG4	VQFN	RHA	40	250	180.0	16.4	6.3	6.3	1.1	12.0	16.0	Q2
CDCU877RHAR	VQFN	RHA	40	2500	330.0	16.4	6.3	6.3	1.1	12.0	16.0	Q2
CDCU877RHARG4	VQFN	RHA	40	2500	330.0	16.4	6.3	6.3	1.1	12.0	16.0	Q2

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CDCU877ANMKR	NFBGA	NMK	52	1000	336.6	336.6	28.6
CDCU877ARHAR	VQFN	RHA	40	2500	353.0	353.0	32.0
CDCU877ARHATG4	VQFN	RHA	40	250	213.0	191.0	35.0
CDCU877RHAR	VQFN	RHA	40	2500	353.0	353.0	32.0
CDCU877RHARG4	VQFN	RHA	40	2500	353.0	353.0	32.0

GENERIC PACKAGE VIEW

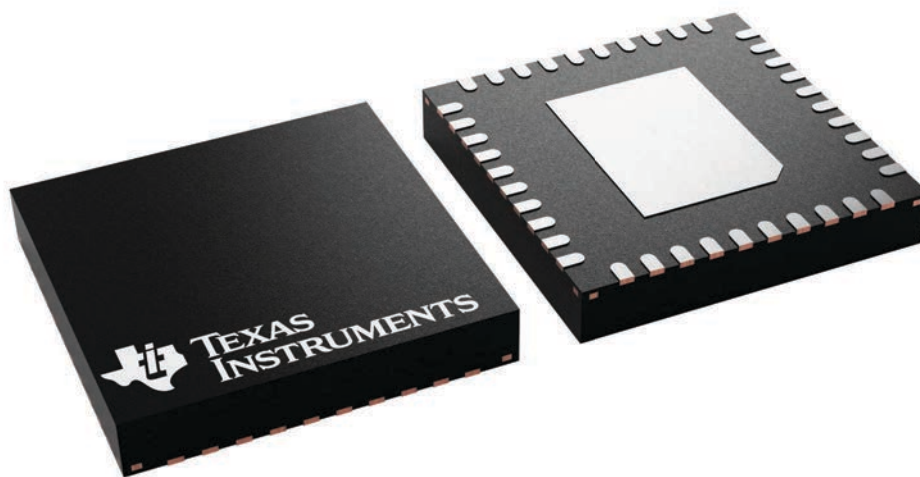
RHA 40

VQFN - 1 mm max height

6 x 6, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

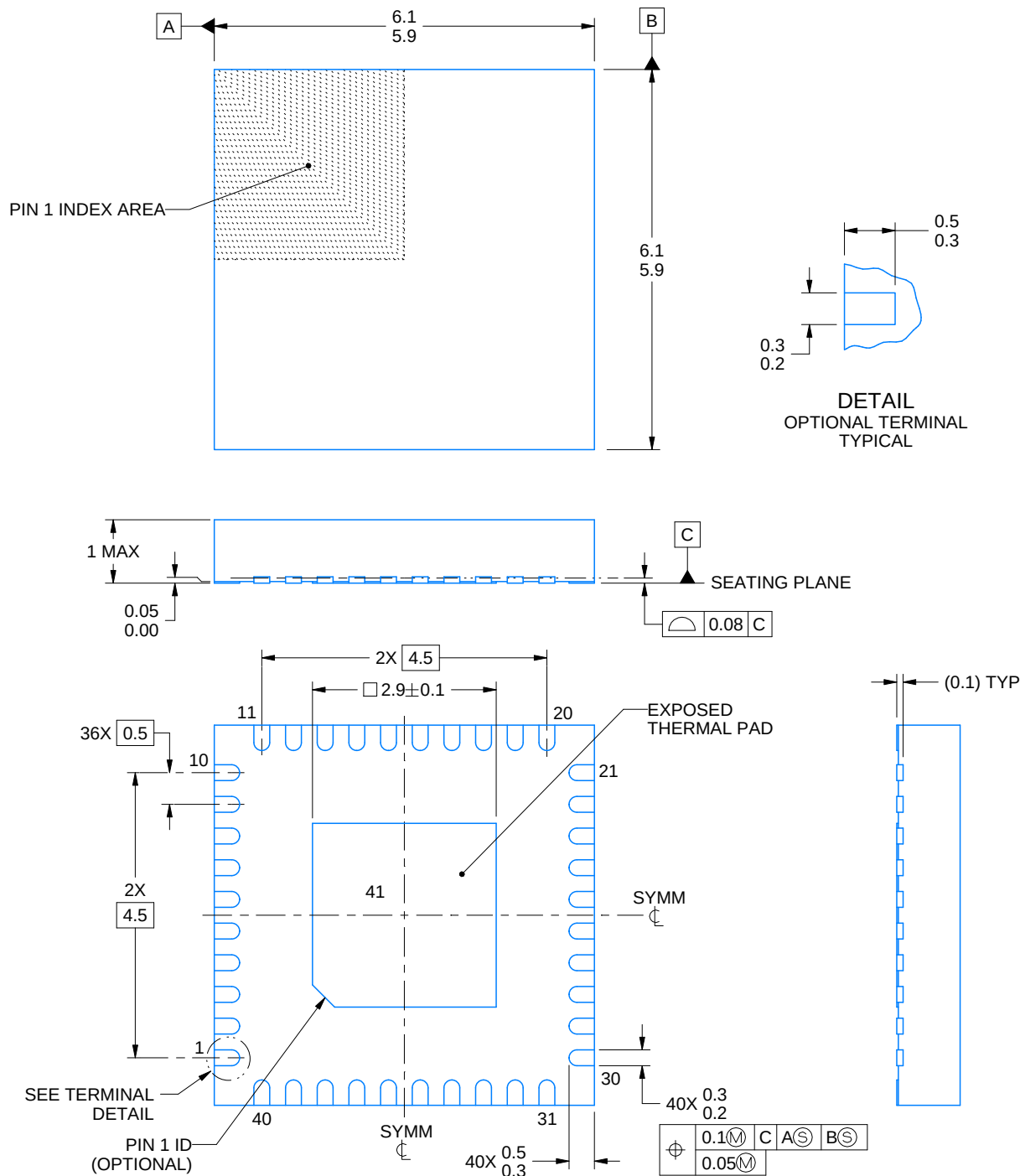
This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.





VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



4225822/A 03/2020

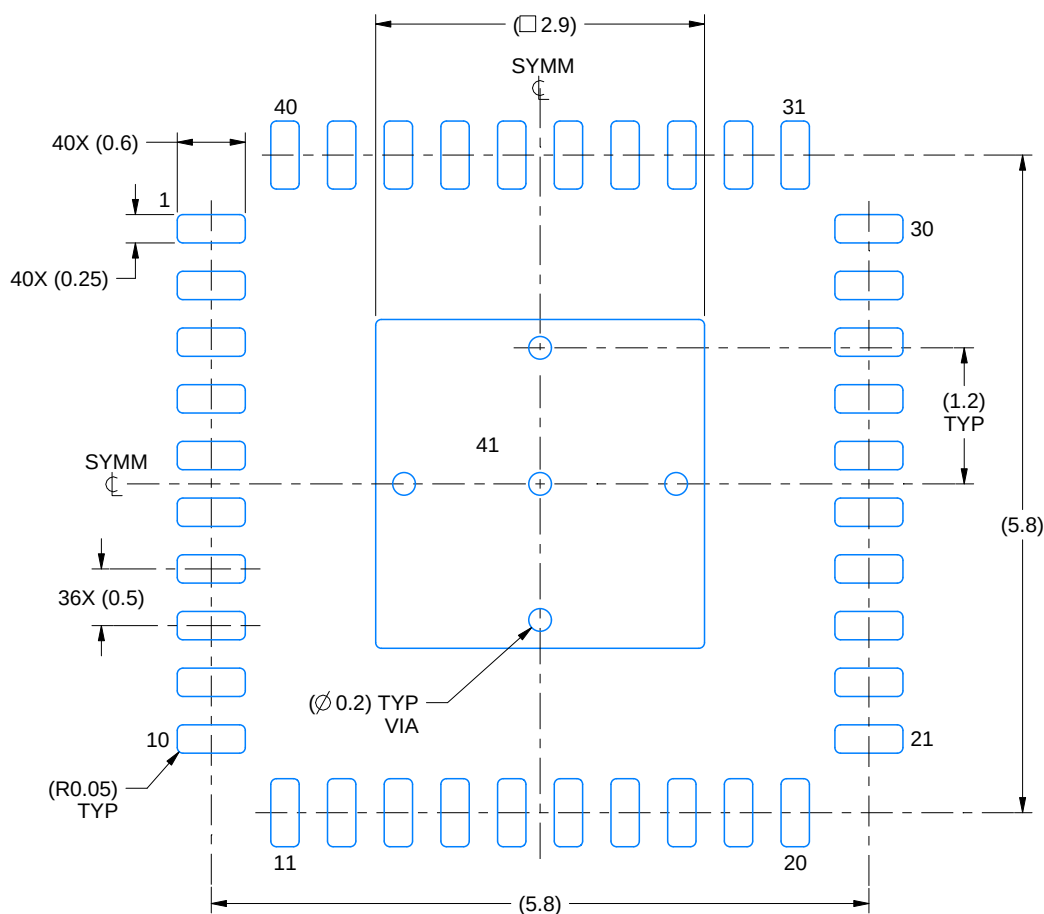
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

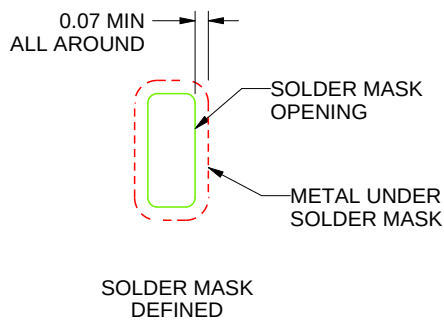
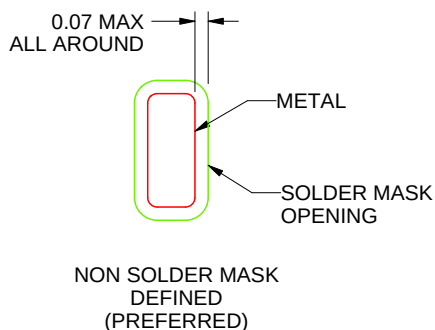
RHA0040D

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
SCALE:15X



SOLDER MASK DETAILS

4225822/A 03/2020

NOTES: (continued)

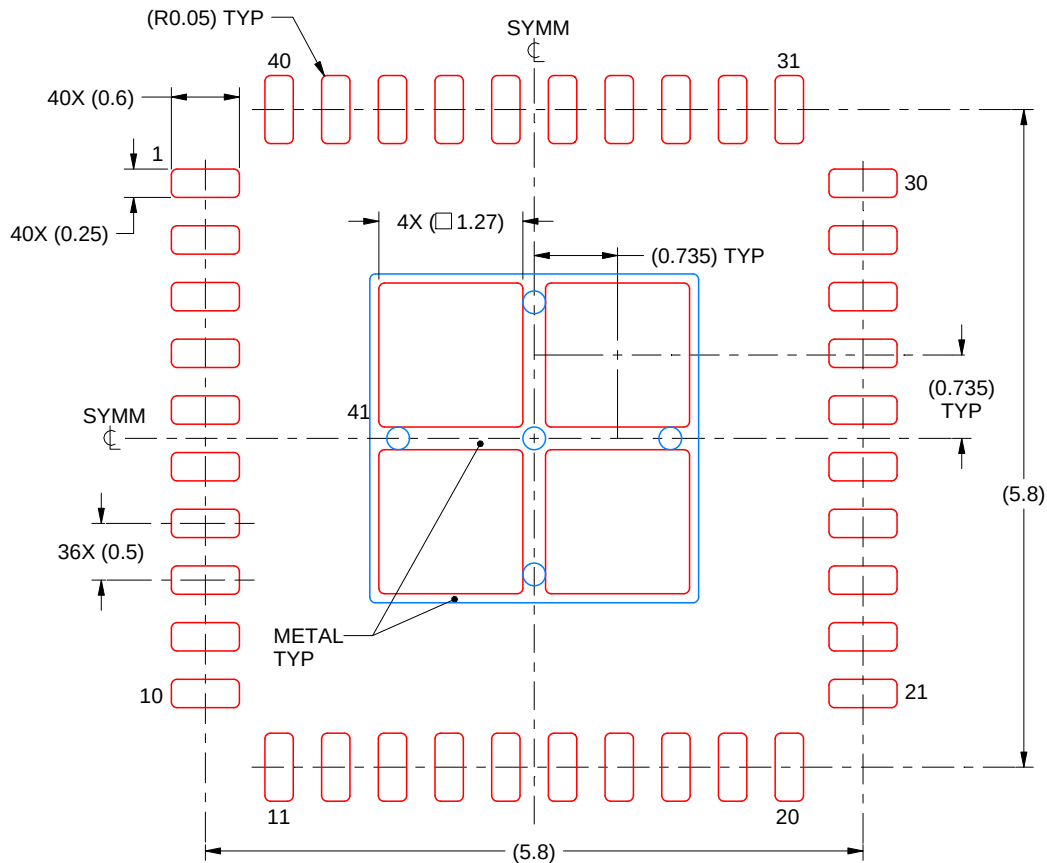
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view.

EXAMPLE STENCIL DESIGN

RHA0040D

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



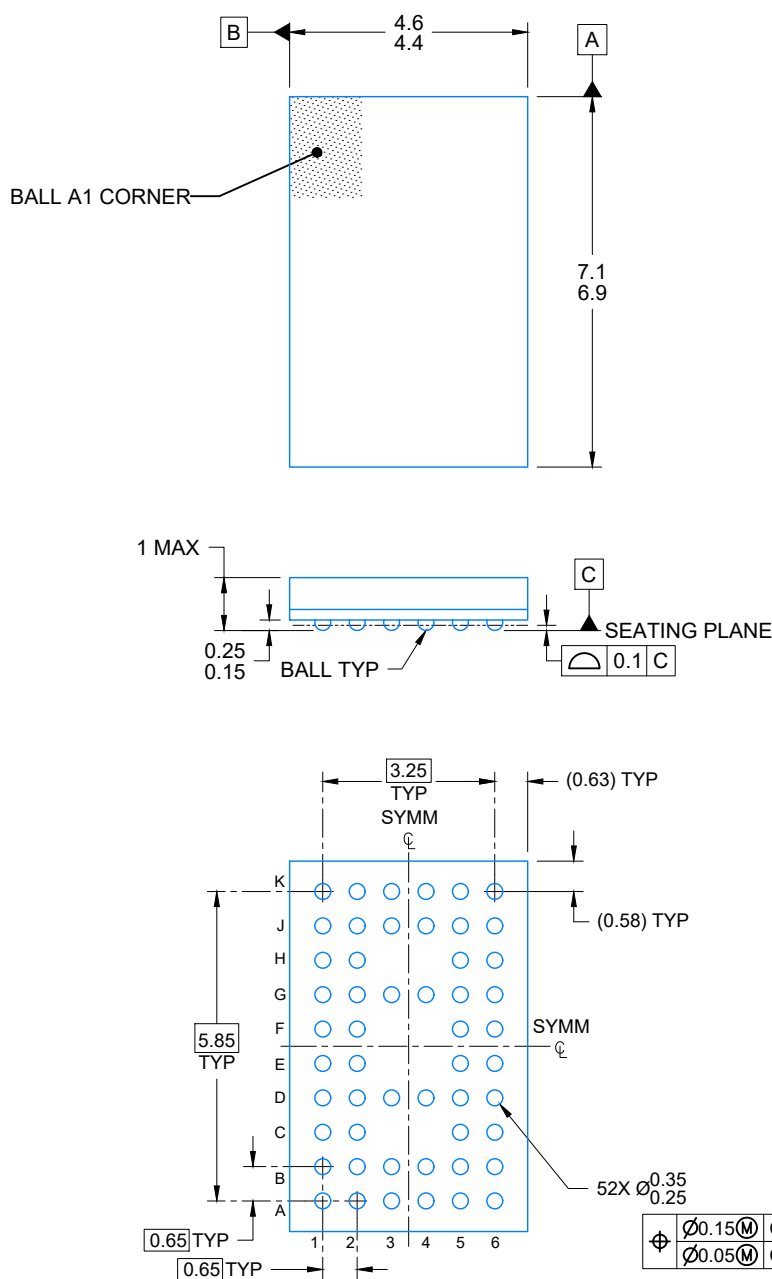
SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD 41:
76.46% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE
SCALE:15X

4225822/A 03/2020

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

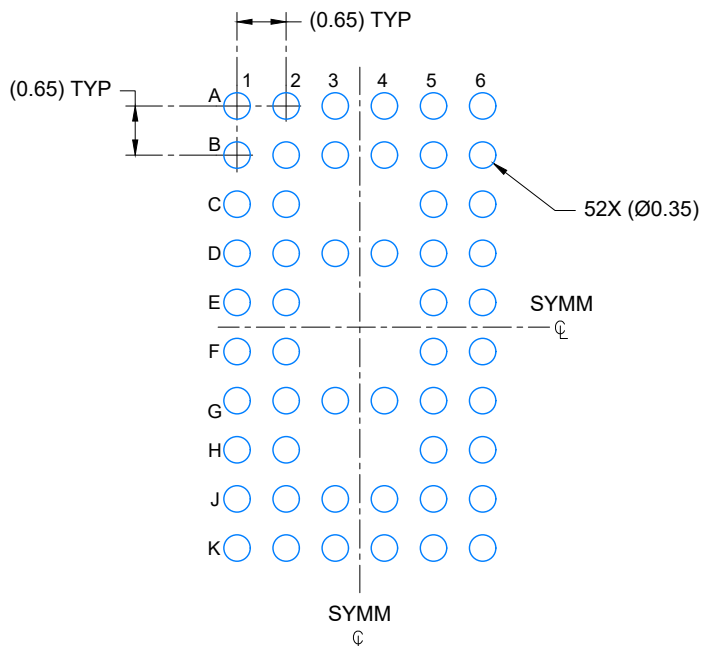


4225135/A 08/2019

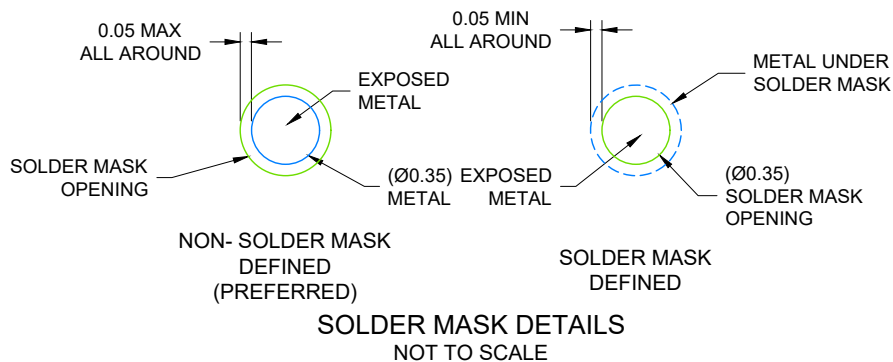
NOTES:

NanoFree is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.



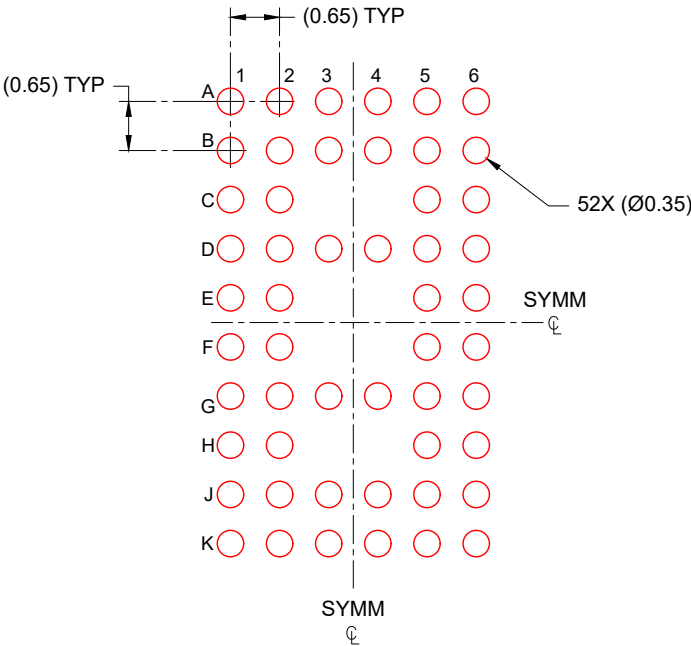
LAND PATTERN EXAMPLE
SCALE: 10X



4225135/A 08/2019

NOTES: (continued)

- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. Refer to Texas Instruments Literature number SNVA009 (www.ti.com/lit/snva009).



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

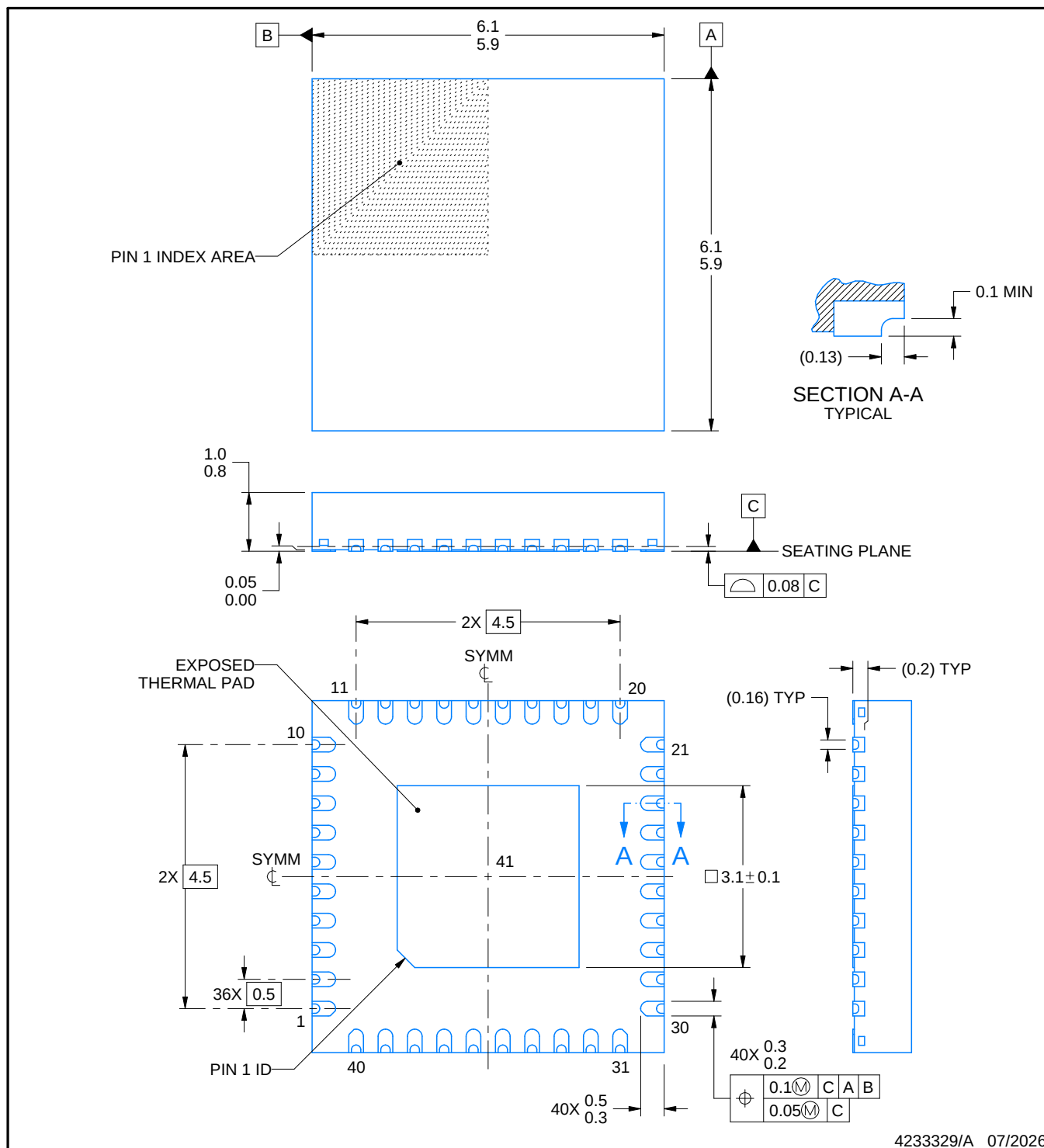
NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

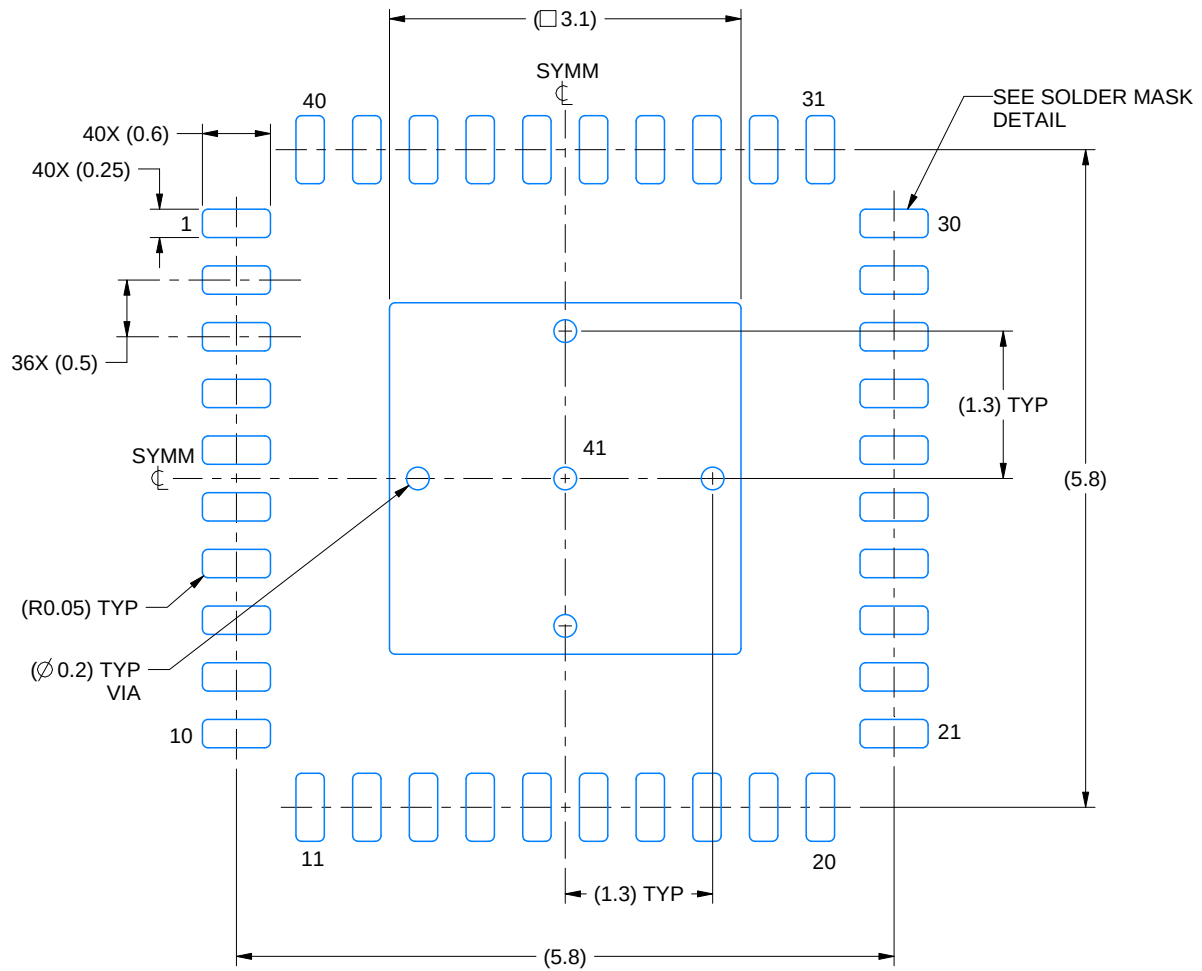
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

EXAMPLE BOARD LAYOUT

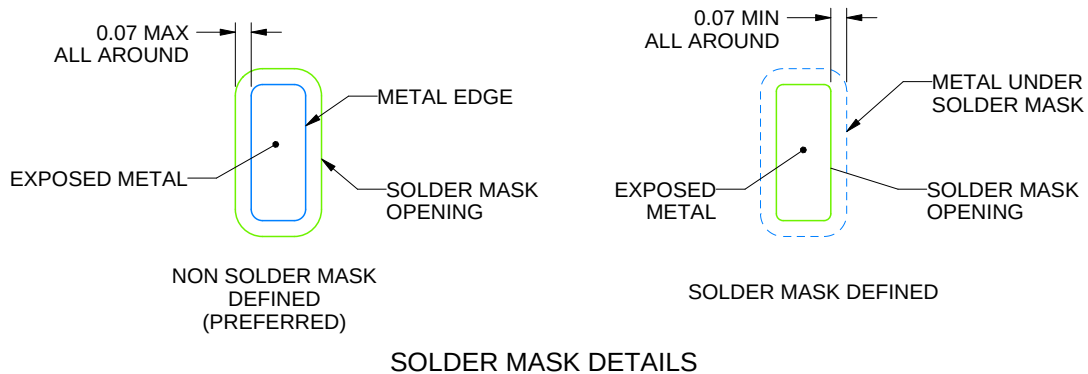
RHA0040Y

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 15X



4233329/A 07/2026

NOTES: (continued)

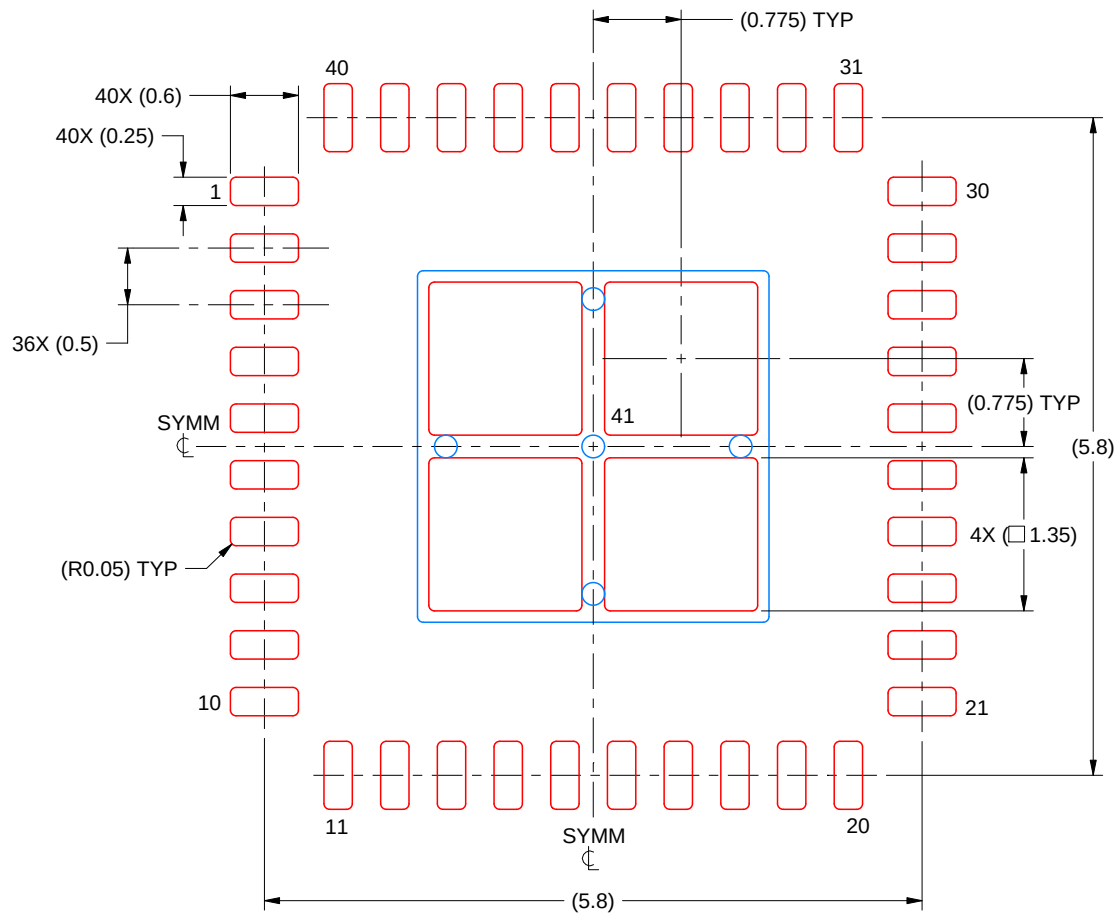
- This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
- Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

RHA0040Y

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE
BASED ON 0.125 MM THICK STENCIL
SCALE: 15X

EXPOSED PAD 41
76% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE

4233329/A 07/2026

NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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Last updated 10/2025